# 14 5 5 40

## **Notice of References Cited**

Application/Control No.

O9/777,158

Applicant(s)/Patent Under Reexamination MENKE, LAURA LEE

Examiner

Thomas E Shortledge

Art Unit
Page 1 of 1

### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0143821	10-2002	Jakubowski, Douglas	707/522
	В	US-6,389,387	05-2002	Poznanski et al.	704/9
	С	US-6,092,036	07-2000	Hamann, Rodney P.	704/8
	D	US-6,182,066	01-2001	Marques, Joaquin M.	707/5
	E	US-6,035,121	03-2000	Chiu et al.	7.17/141
	F	US-5,434,776	07-1995	Jain, Naveen K.	704/8
	G	US-6,115,715	09-2000	Traversat et al.	707/100
	Н	US-2001/0044809	11-2001	Parasnis et al.	707/513
	ı	US-			
	J	US-			
	к	US-			10
	L	US-			
	М	US-			

#### **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	,				
	0					
	Р					
	Q					
	R	·				
	s					
	Т					

#### **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.